

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/537,297	QUER ET AL.
Examiner	Art Unit	
Helen C. Kwok	2856	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
73	514.15	6/6/2006	HK
73	514.29	6/6/2006	HK
73	514.38	6/6/2006	HK